


<b>Search Notes</b> 	<b>Application/Control No.</b> 10536685	<b>Applicant(s)/Patent Under Reexamination</b> HECKL ET AL.
	<b>Examiner</b> D L Jones	<b>Art Unit</b> 1618

SEARCHED			
Class	Subclass	Date	Examiner
424	1.11, 1.49, 1.65, 1.69, 1.81, 1.85, 1.89, 9.1, 9.2, 9.3, 9.4, 9.5, 9.6, 9.7, 9.8	3/23/10	dj
514	2, 5, 6, 7, 9, 13, 14, 15, 16, 17, 18, 19	3/23/10	dj
530	300, 317, 324, 325, 326, 327, 328, 329, 330, 331	3/23/10	dj

SEARCH NOTES		
Search Notes	Date	Examiner
inventors search; consulted parent application; reviewed SCORE data; STN; sequence search	3/23/10	dj

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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